FO	RM	PT	·O-	144	9				u s		FP	ARI	MENT	Т	ATT	Y. DOCKE		\neg	SEE	ZIAI	NO.:	
															NO.: TIMK 8736US				 1	TUNE TO.		
	INFORMATION DISCLOSURE A STATEMENT BY APPLICANT															APPLICANT: Xiaolan Ai, et al.						
	(Use several sheets if necessary)														Filing Date: Gro				Gro	up:		
	U.S. PATENT D																			- 	-	
Examiner															Patent Issue Date OR							
Initial	Document Number												Kind Code (click here	de US Non-Published Ap			e OR					
106									_	1	9	1			May 25, 1999				Sasa	aki et al		
								1	4	5	7	5			June 22, 1999					Sasaki		
	US	\vdash	⊢	$\vdash \vdash$	_	5 9 9 1 6 8 3 6 4 7 8 7 0 5						3		November 23, 1999 November 12, 2002						Takaoka, et al Holmes et al.		
100	US					0	17 17 17 10 13					۲		November 12, 2002			102			Tibilites et al.		
	us	_						1			t	T										
	US																					
	US	_	_	Ш			_	1	_	L	 	<u> </u>									<u> </u>	
	US	_	⊢	Н	\dashv	_	┝	╁		⊢	⊢	⊢				· · · · · · · · · · · · · · · · · · ·				—		
	US						\vdash															
			Ь				<u> </u>	1	1	FΩ	RF	G	N PAT	FN	TD	OCUMENT	S					
	FOREIGN PATENT DOCUMENTS Examiner Translation														1							
	Initial			I	Document Number								Date		Country		Yes					
	- [ÍĠ	Z				6				3 A				Europe		ζ]	
								6				3 A			9	Europe			ᆚ			
			4		_		_		_	_	_	22	5.1.			PCT	_	Κ	+			
	1		A	$\frac{1}{\sqrt{2}}$	┵	2 2	2	4	2	6	5	8	5.30	J.U2	<u>. </u>	PCT		Κ	-			
	1				=K	DO	$\frac{1}{2}$:111	ИF	NT	SI	Inc	ludino	Α	uth	or, Title, Da	ate	Perti	iner	ıt Pa	nes Etc.)	
		Т	<u> </u>	ΪÏ							<u> </u>		idding	, , ,	-	51, 11clo, 50	100,				gco, Lto.,	
				П																		
		1		П						•				-								
		-		П		_										·	•	•				
			_										-									
•																			-			
EXA	EXAMINER & Lew &													D.	DATE CONSIDERED 9 123 104							
			`		//	//		_	_					_				1	7	/		
MPE	P 6	09.		raw	v lir	ne	thi	rou	gh	cit	atic	n i		CO	nfoi	not citation irmance and						
رعتت	<u> </u>	.											· · · ·	<u> </u>				<u>(</u>	Forn	n PT	O-1449)	